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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/633,499	08/05/2003	Srikanteswara Dakshina-Murthy	H1134	5215
7590 06/10/2004			EXAMINER	
HARRITY & SNYDER, L.L.P.			LE, THAO P	
Suite 300 11240 Waples Mill Road			ART UNIT	PAPER NUMBER
Fairfax, VA 22030			2818	
			DATE MAILED, OCUO/2004	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)				
Office Action Summer	10/633,499	DAKSHINA-MURTHY ET AL.				
Office Action Summary	Examin r	Art Unit				
	Thao P. Le	2818				
The MAILING DATE of this communication a Period for Reply	ppears on the cover shet with the c	orrespond nc address				
A SHORTENED STATUTORY PERIOD FOR REP THE MAILING DATE OF THIS COMMUNICATION  - Extensions of time may be available under the provisions of 37 CFR after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a relif NO period for reply is specified above, the maximum statutory perions after the period for reply within the set or extended period for reply will, by state Any reply received by the Office later than three months after the main earned patent term adjustment. See 37 CFR 1.704(b).	1.  1.136(a). In no event, however, may a reply be tineply within the statutory minimum of thirty (30) day will apply and will expire SIX (6) MONTHS from the cause the application to become ABANDONE	nely filed s will be considered timely. the mailing date of this communication. D (35 U.S.C. § 133).				
Status	1					
1) Responsive to communication(s) filed on 05	May 2004.					
	nis action is non-final.					
3) Since this application is in condition for allow						
Disposition of Claims						
<ul> <li>4)  Claim(s) 1-19 is/are pending in the application 4a) Of the above claim(s) is/are withdrest</li> <li>5)  Claim(s) is/are allowed.</li> <li>6)  Claim(s) 1-9 is/are rejected.</li> <li>7)  Claim(s) 10-14 is/are objected to.</li> <li>8)  Claim(s) are subject to restriction and</li> </ul>	rawn from consideration.					
Application Papers						
9)⊠ The specification is objected to by the Examiner.						
	)⊠ The drawing(s) filed on <u>05 August 2003</u> is/are: a)⊠ accepted or b)□ objected to by the Examiner.					
	Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).					
11) The oath or declaration is objected to by the		•				
Priority under 35 U.S.C. § 119						
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of:  1. Certified copies of the priority docume 2. Certified copies of the priority docume 3. Copies of the certified copies of the priority docume application from the International Bure * See the attached detailed Office action for a life.	ents have been received. ents have been received in Applicationity documents have been received and (PCT Rule 17.2(a)).	ion No ed in this National Stage				
Attachment(s)	_					
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	4) 🔲 Interview Summary Paper No(s)/Mail D					
<ol> <li>Notice of Draftsperson's Patent Drawing Review (P10-948)</li> <li>Information Disclosure Statement(s) (PTO-1449 or PTO/SB/0 Paper No(s)/Mail Date 8/5/03.</li> </ol>		Patent Application (PTO-152)				

### **DETAILED ACTION**

#### Oath/Declaration

1. The oath/declaration filed on 8/5/03 is acceptable.

#### Election/Restriction

2. Application's election **without traverse** of claims 1-14 is acknowledged. Applicants have the right to file a divisional, continuation or continuation-in-part application covering the subject matter of the non-elected claims.

#### Information Disclosure Statement

3. Information Disclosure Statement (IDS) filed on **8/5/03** and made of record. The references cited on the PTOL 1449 form have been considered.

## Specification

4. Applicant is reminded of the proper content of an abstract of the disclosure.

A new abstract is required that is clearly indicative the invention to which the claims are directed. Note that, the claims are directed to a method of forming a fin for a fin field effect transistor, the claims are directed to a method of making a semiconductor device instead of to a semiconductor device.

The length of abstract should be between 50-150 words.

A patent abstract is a concise statement of the technical disclosure of the patent and should include that which is new in the art to which the invention pertains. If the patent is of a basic nature, the entire technical disclosure may be new in the art, and the abstract should be directed to the entire disclosure. If the patent is in the nature of an improvement in an old apparatus, process, product, or composition, the abstract should include the technical disclosure of the improvement. In certain patents, particularly those for compounds and compositions, wherein the process for making and/or the use thereof are not obvious, the abstract should set forth a process for making and/or use thereof. If the new technical disclosure involves modifications or alternatives, the abstract should mention by way of example the preferred modification or alternative.

The abstract should not refer to purported merits or speculative applications of the invention and should not compare the invention with the prior art.

Where applicable, the abstract should include the following:

- (1) if a machine or apparatus, its organization and operation;
- (2) if an article, its method of making;
- (3) if a chemical compound, its identity and use;
- (4) if a mixture, its ingredients;
- (5) if a process, the steps.

Extensive mechanical and design details of apparatus should not be given.

## Claim Rejections

# Claim Rejections - 35 USC § 102

5. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless --

(e) the invention was described in a patent granted on an application for patent by another filed in the United States before the invention thereof by the applicant for patent, or on an international application by another who has fulfilled the requirements of paragraphs (1), (2), and (4) of section 371(c) of this title before the invention thereof by the applicant for patent.

The changes made to 35 U.S.C. 102(e) by the American Inventors Protection Act of 1999 (AIPA) and the Intellectual Property and High Technology Technical Amendments Act of 2002 do not apply when the reference is a U.S. patent resulting directly or indirectly from an international application filed before November 29, 2000. Therefore, the prior art date of the reference is determined under 35 U.S.C. 102(e) prior to the amendment by the AIPA (pre-AIPA 35 U.S.C. 102(e)).

6. Claims 1-9 are rejected under 35 U.S.C. 102(e) as being anticipated by Buynoski et al., U.S. Patent No. 6,709,982.

The applied reference has a common assignee and a common inventor with the instant application. Based upon the earlier effective U.S. filing date of the reference, it constitutes prior art under 35 U.S.C. 102(e). This rejection under 35 U.S.C. 102(e)

might be overcome either by a showing under 37 CFR 1.132 that any invention disclosed but not claimed in the reference was derived from the inventor of this application and is thus not the invention "by another," or by an appropriate showing under 37 CFR 1.131.

Regarding to claim 1, Buynoski et al. discloses a method of forming a fin for a fin field effect transistor (See Figs. 1-7 and Cols. 1-6), comprising:

- defining a trench 300 in a layer of first material 230 (Fig. 3);
- growing a second material 410 in the trench to form the fin (Fig. 4);
- removing the layer of first material (Fig. 7; lines 38-40, Col. 3).

Regarding to claim 2, Buynosky et al. discloses the limitations as applied for claim 1 above and further discloses wherein the first material comprises an oxide (oxide 230, Fig. 3).

Regarding to claim 3, Buynosky et al. discloses the limitations as applied for claim 1 above and further discloses wherein defining a trench comprises:

- forming the layer of first material on a substrate (Fig. 2);
- selectively etching the layer to define the trench (Fig. 3; lines 1-10, Col. 3).

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Regarding to claim 4, Buynosky et al. discloses the limitations as applied for claim 1 above and further discloses wherein growing the second material comprises epitaxially growing the second material (lines 16-20, Col. 3).

Regarding to claim 5, Buynosky et al. discloses the limitations as applied for claim 1 above and further discloses wherein removing the layer of first material by etching or some other conventional technique (Fig. 7; lines 38-40, Col. 3). It is inherent that stripping technique is included in conventional technique that used to removing the layer.

Regarding to claim 6, Buynosky et al. discloses the limitations as applied for claim 1 above and further discloses forming a spacer on an upper surface of the fin (SiN or SiO, lines 55-57, Col. 3).

Regarding to claim 7, Buynosky et al. discloses the limitations as applied for claims 1, and 6 above and further discloses wherein forming the spacer comprises depositing a third material on the upper surface (SiN or SiO, lines 55-57, Col. 3).

Regarding to claim 8, Buynosky et al. discloses the limitations as applied for claims 1, 6, and 7 above and further discloses wherein the third material comprises a nitride (SiN, lines 55-57, Col. 3).

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Regarding to claim 9, Buynosky et al. discloses the limitations as applied for claim 1 above and further discloses wherein the second material 410 comprises silicon (Fig. 4).

## Reasons for Indication of Allowable Subject Matter

- 7. Claims 10-14 are **objected** to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims, since the prior made of record and considered pertinent to the applicant's disclosure does not teach or suggest the claimed limitations that recite in base claims and further including a step of forming a liner on the spacer and fin whereas the liner comprising a third material.
- 8. When responding to the office action, Applicants' are advice to provide the examiner with the line numbers and page numbers in the application and/or references cited to assist the examiner to locate the appropriate paragraphs.

A shortened statutory period for response to this action is set to expire 3 (three) months and 0 (zero) day from the day of this letter. Failure to respond within the period for response will cause the application to become abandoned (see M.P.E.P 710.02(b)).

## Conclusion

9. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Thao P. Le whose telephone number is 571-272-1785. The examiner can normally be reached on M-T (7-6).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David Nelms can be reached on 571-272-1787. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Thao P. Le Examiner Art Unit 2818